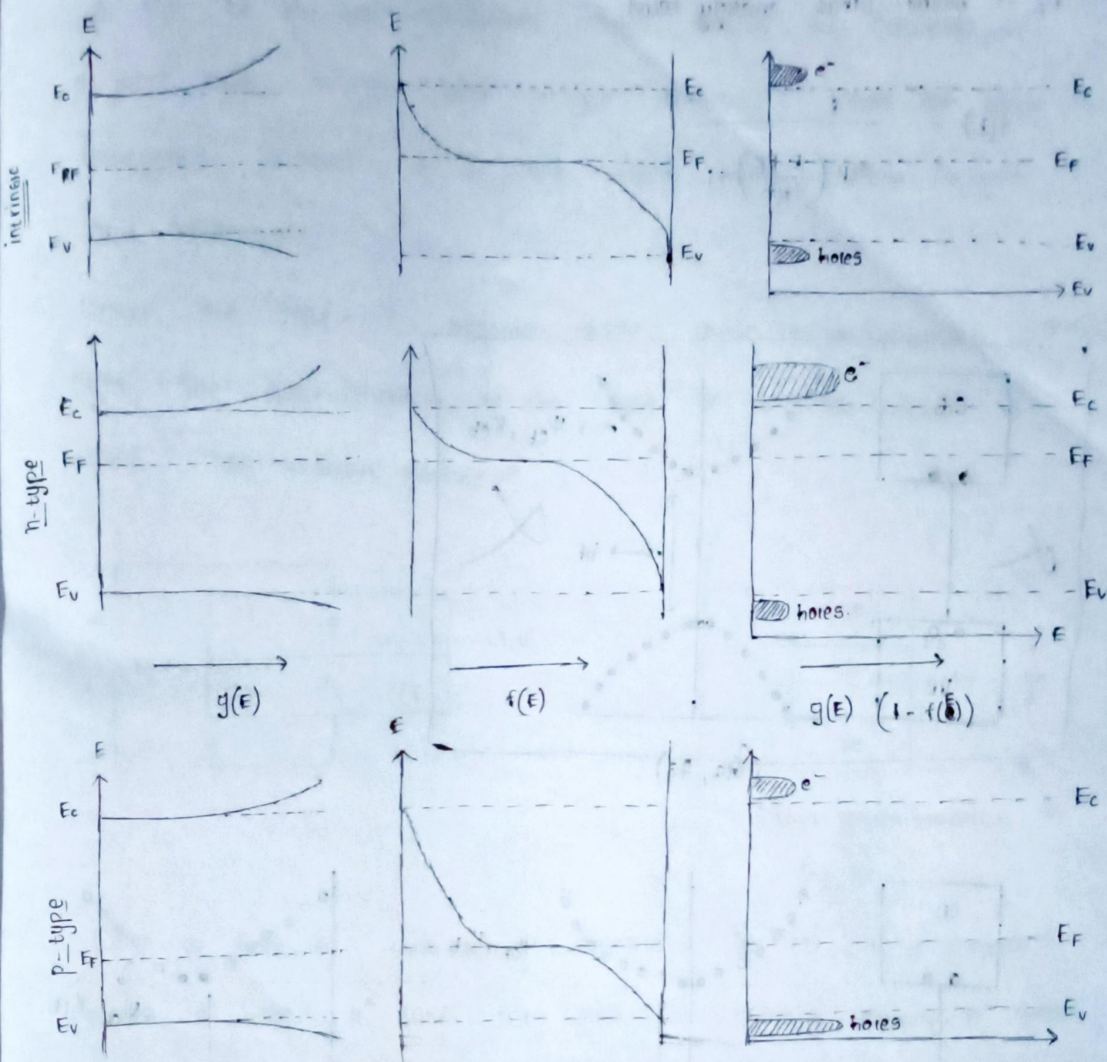


SEMI CONDUCTOR



$$n_i = N_{eff} \exp \left[-\frac{(E_F - E_i)}{KT} \right]$$

$$p_i = N_{eff} \exp \left[-\frac{(E_i - E_v)}{KT} \right]$$

$N_v \Rightarrow$ eff. DOS in valence band

$N_c \Rightarrow$ effective density of states (DOS) in conduction band.

$$N_c = 2.8 \times 10^{19} \text{ per cm}^3 \text{ Si at } 300 \text{ K}$$

$$N_v = 1.02 \times 10^{19} \text{ per cm}^3 \text{ Si at } 300 \text{ K}$$

$$N_c = 2 \left[\frac{2\pi m_e^* KT}{h^2} \right]^{3/2}$$

$$N_v = 2 \left[\frac{2\pi m_h^* KT}{h^2} \right]^{3/2}$$

$g(E) \rightarrow$ no. of states per unit vol. per unit energy.

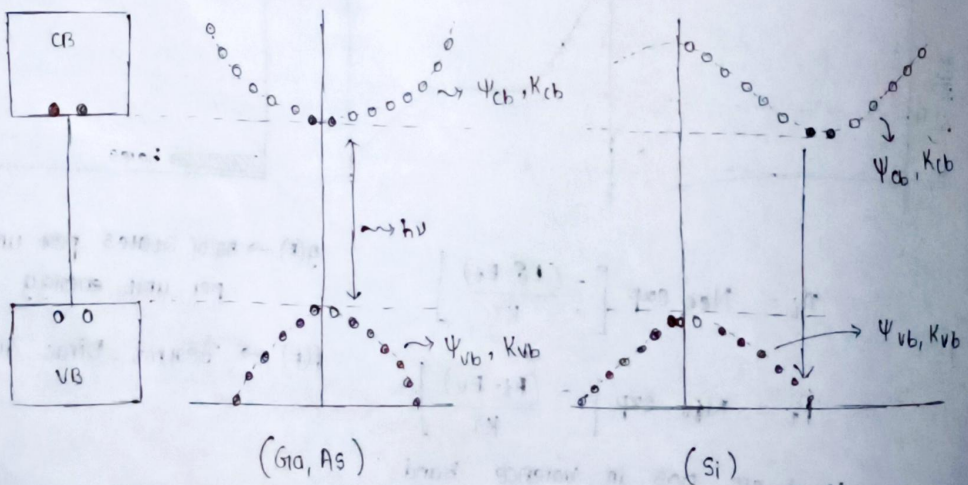
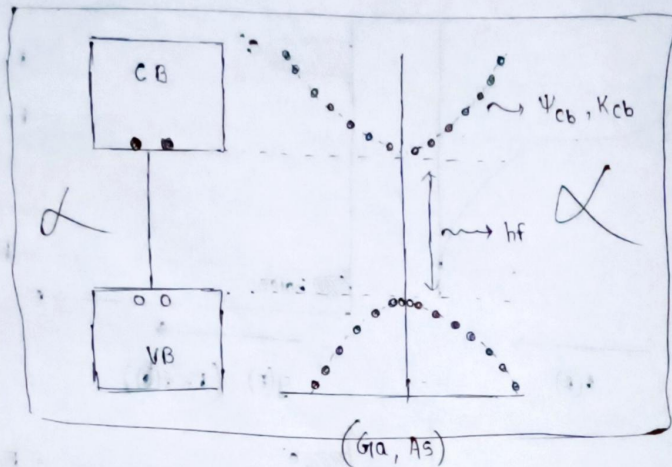
$f(E) \rightarrow$ Fermi-Dirac distribution.

$E_c \rightarrow$ bottom of conduction band level

$E_v \rightarrow$ top of valence band level

$E_F \rightarrow$ Fermi-Dirac energy level

$$f(E) = \frac{1}{\exp\left(\frac{E-E_F}{kT}\right) + 1}$$



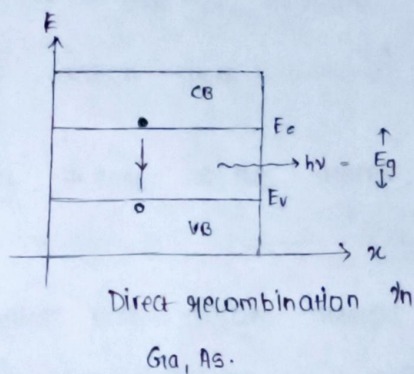
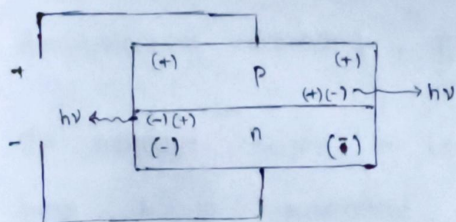
Direct bandgap.

Indirect band gap.

Direct Emitting Diode (LED)

A LED is a semi-conductor diode made by creation of a junction with n-type and p-type materials. When the diode is forward biased, e^- & holes enter the depletion region and recombine.

Unlike the case of regular diode these recombinations produce light. The recombination in the case of regular diode is called non-radiative.



When a free e^- wandering around in CB, if a crystal meets a hole, it falls into this low energy empty e^- state. This process is called recombination.

- * Intuitively, recombination corresponds to the free e^- finding an incomplete bond with a missing e^- . The e^- then enters and completes this bond. The free e^- in CB and free hole in VB are consequently annihilated. On energy band diagram, the recombination process is represented by returning the e^- from CB (where it is free) into the hole in VB (where it is in a bond).

RESPONSIVITY (R) and QUANTUM EFFICIENCY (η)

* This is regarding P-N photodiode.

* The input for a photodiode is light power. We denote it as P . The output current is known as photocurrent which is denoted by I_p .

* The photocurrent is proportional to the light power.

$$I_p \propto P$$

$$(or) \quad I_p = RP \quad \rightarrow \text{proportionality const: known as responsivity.}$$

* We know the photocurrent is the no. of e^- (N_e) times the charge of e^- (e) per unit time i.e.

$$I_p = \frac{N_e e}{t}$$

* On the otherhand, light power is light energy per unit time, where the light energy is equal to energy of photon (E_p) times the no. of photons (N_p) over time.

$$P = \frac{N_p E_p}{t}$$

* By substituting $E_p (\equiv h\nu \equiv \frac{hc}{\lambda})$, we have following result.

$$R = \frac{I_p}{P} = \left(\frac{N_e}{N_p} \right) \left(\frac{e\lambda}{hc} \right) = \eta \left(\frac{e\lambda}{hc} \right)$$

$$\therefore \boxed{R = \eta \frac{e\lambda}{hc}} \quad A/W.$$

Q. A Si P-I-N photodiode has efficiency of 0.7 at wavelength $0.85 \mu\text{m}$. Compute R .

Sol^y $R = \eta \frac{e\lambda}{hc} = (0.7) \cdot \frac{(1.6 \times 10^{-19}) (0.85 \times 10^{-6})}{(6.6 \times 10^{-34}) (3 \times 10^8)} = \underline{\underline{0.479 \text{ A/W}}}$

Q. When 2.5×10^{12} photons generated by a laser source of wavelength $0.85 \mu\text{m}$ are incident on photodiode, $1.5 \times 10^{12} e^-$ on average are collected at the output terminals. Compute η -efficiency and Responsivity of photodiode at above wavelength.

Sol^y $\therefore \eta = \frac{N_e}{N_p} = \frac{1.5 \times 10^{12}}{2.5 \times 10^{12}} = 0.6$

$\therefore R = (0.6) \frac{(1.6 \times 10^{-19}) (0.85 \times 10^{-6})}{(6.6 \times 10^{-34}) (3 \times 10^8)} = \underline{\underline{0.411 \text{ A/W}}}$

Q. A PIN photodiode has quantum efficiency 70% for photons of energy $1.52 \times 10^{-19} \text{ J}$. Calculate:

i) Calculate the wavelength at which the diode is operating.

ii) Calculate the optical power required to achieve a photocurrent of $3 \mu\text{A}$.

Sol^y $\lambda = \frac{hc}{E} = 1.3 \mu\text{m}$

~~R = \eta \frac{e\lambda}{hc}~~ $R = \eta \frac{e\lambda}{hc} = 0.738 \text{ A/W}$

$\therefore P = \frac{I_p}{R} = \frac{3 \mu\text{A}}{0.738} = \underline{\underline{4.07 \mu\text{W}}}$

⇒ A PIN photodiode, on an avg generates one e^- -hole pair per two incident photons at $\lambda = 0.85 \mu\text{m}$. Assuming the photogenerated e^- are collected, compute the following:

i) Q -efficiency of diode

ii) the max possible bandgap energy in eV of the semiconductor, assuming the incident wavelength to be long wavelength cutoff.

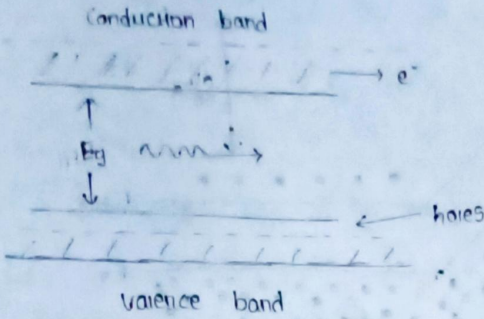
iii) the mean output photocurrent when the incident optical power is $10 \mu\text{W}$

Soln) i) $\eta = \frac{1}{2} = 50\%$

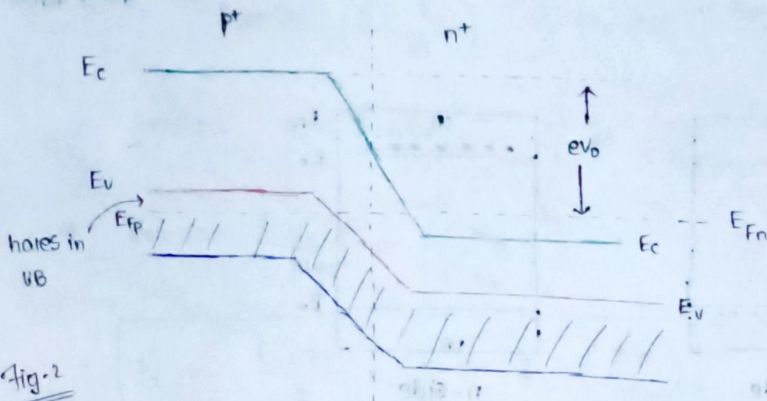
ii) $E = \frac{hc}{\lambda} = 1.46 \text{ eV}$
 \swarrow $0.85 \mu\text{m}$

iii) $I_p = RP = 3.42 \mu\text{A}$

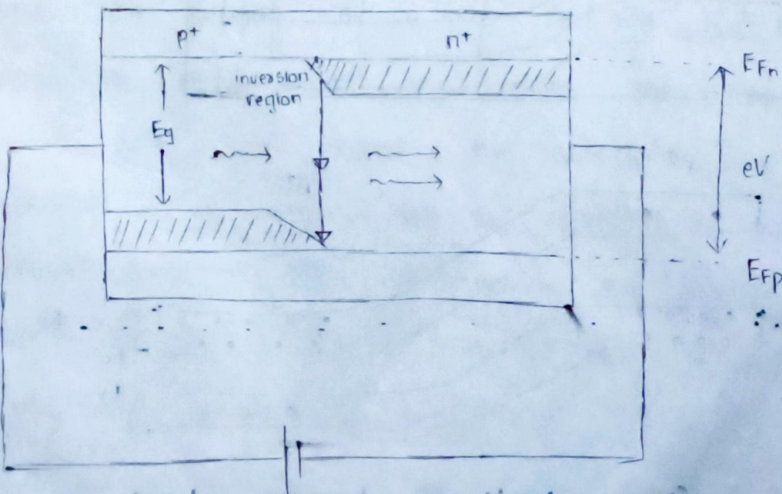
LASER: DIODE



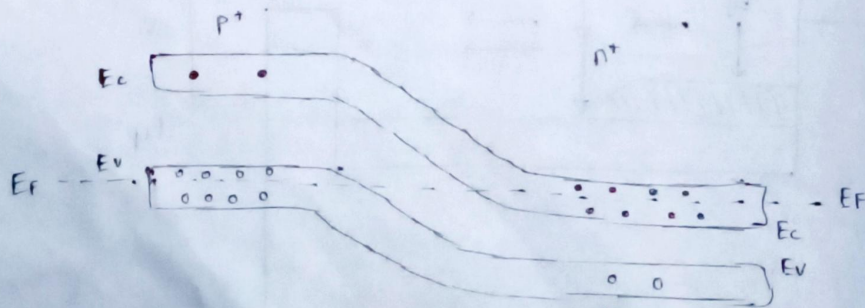
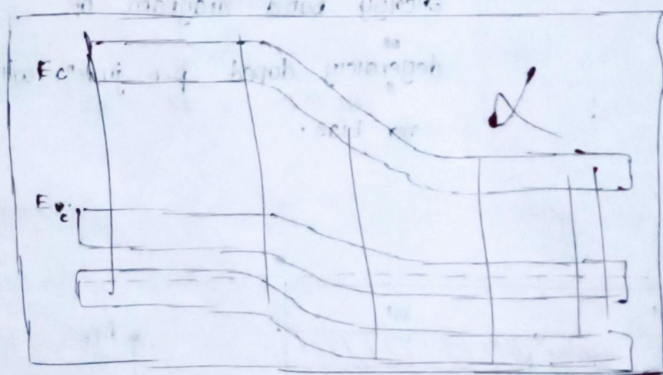
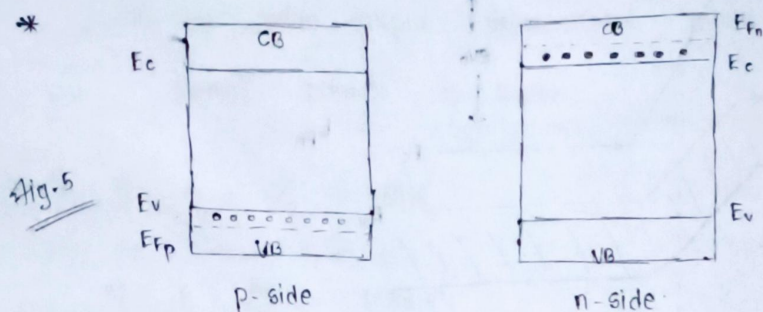
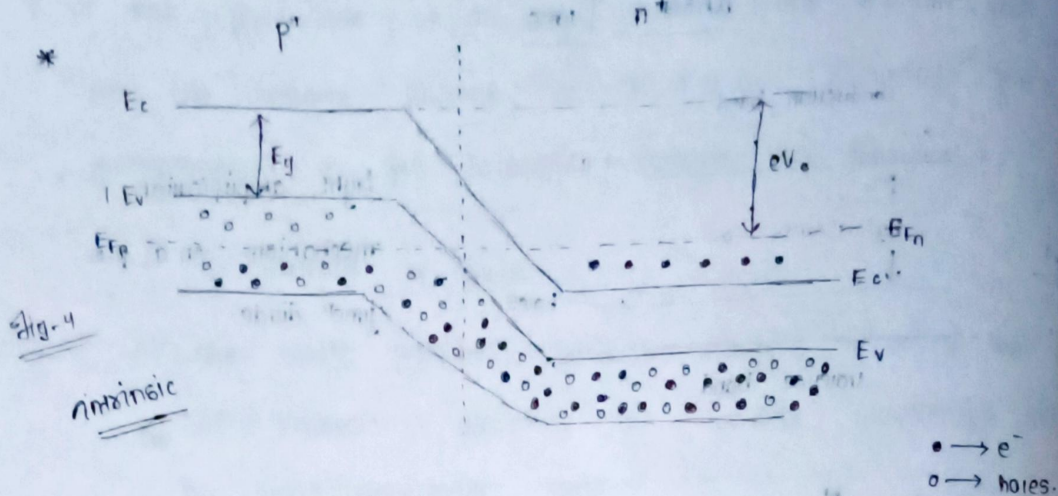
Light amplification mechanism in a p-n junction diode.



Energy band diagram of degenerately doped p-n junction with no bias.



Band diagram with sufficiently large forward bias.



Energy bands of heavily doped
PN Junction.

Stage-1: In an intrinsic material, if

$$E_v + 3KT \leq E_f \leq E_c - 3KT$$

$$n = N_{oc} \exp\left(\frac{E_f - E_c}{KT}\right)$$

USE

Fig-4

$$p = N_{ov} \exp\left(\frac{E_v - E_f}{KT}\right)$$

* Substituting $n=p$ and

Set

$$E_f = E_i$$

$$N_{oc} \exp\left(\frac{E_i - E_c}{KT}\right) = N_{ov} \exp\left(\frac{E_v - E_i}{KT}\right)$$

* Solving $E_i = \frac{E_v + E_c}{2} + \frac{KT}{2} \ln\left(\frac{N_{ov}}{N_{oc}}\right)$

* But $\left(\frac{N_{ov}}{N_{oc}}\right) = \left(\frac{m_p}{m_n}\right)^{3/2}$

$$* \quad E_i = \frac{E_c + E_v}{2} + \frac{3}{4} KT \ln\left(\frac{m_p}{m_n}\right)$$

where $E_g = E_c - E_v$

Stage-2: When a current is passed through PN junction

under forward bias, the injected e^- and holes in VB will increase the density of e^- in CB and holes in VB.

Just thus at some value of current the stimulated emission rate will exceed the absorption rate and amplification will begin. As the current is further increased at some threshold value of current the amplification will overcome the losses in the cavity and laser will begin to emit coherent radiation.

USE Fig-3

Stage-3: Consider degenerately doped direct bandgap semiconductor PN junction, whose band diagram is given.

By degenerate doping we mean that E_{Fp} (Fermi-level in p-side) is in VB and E_{Fn} (Fermi-level in n-side) is in the CB. All energy levels upto Fermi level can be taken to be occupied by e. In the absence of applied voltage, the Fermi level is continuous across the diode $E_{Fp} = E_{Fn}$.

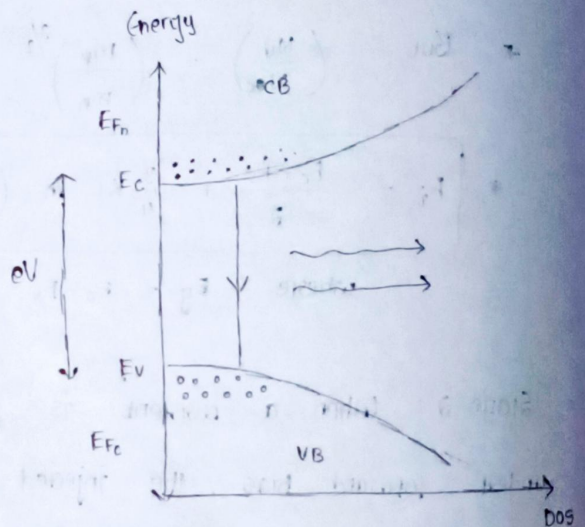
Fig-2

Fig-5

Stage-4:

The DOS and energy distribution of e and holes in CB, VB resp. under forward bias of \rightarrow

$$E_{Fn} - E_{Fp} > E_g$$



* Suppose PN junction diode is forward biased by voltage

V is greater than bandgap voltage $eV > E_g$.

* The separation b/w E_{Fn} & E_{Fp} is now the applied potential energy or eV . The applied voltage diminishes the built-in potential barrier to almost zero, which means that the e flow into SC, which means that the e flow into and flow over the p^+ side to constitute the diode current.

→ The final result is that e^- from n^+ side and holes from p^+ side flow into SC region is no longer depleted.